

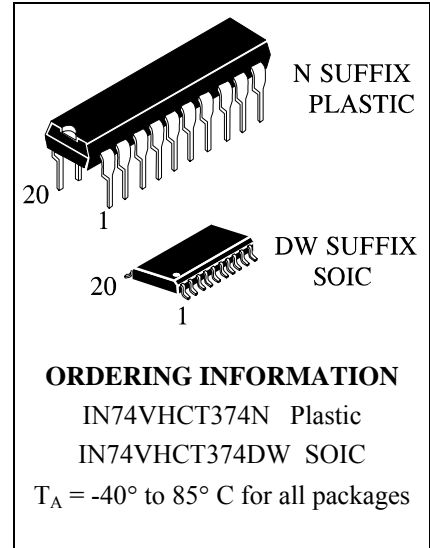
**IN74VHCT374**

**Octal D-type flip-flop (3-state)**

IN74VHCT374 is designed for using in up-to-date high performance computers, high-level electronic equipment for mass application.

IN74VHCT374 is identical in pinout to the series IN74HC374A, IN74HCT374A, IN74AC374A, IN74ACT374A.

Input voltage levels are compatible with standard TTL-levels. Output voltage levels are compatible with input levels of C-MOS, N-MOS and TTL ICs.



**Features :**

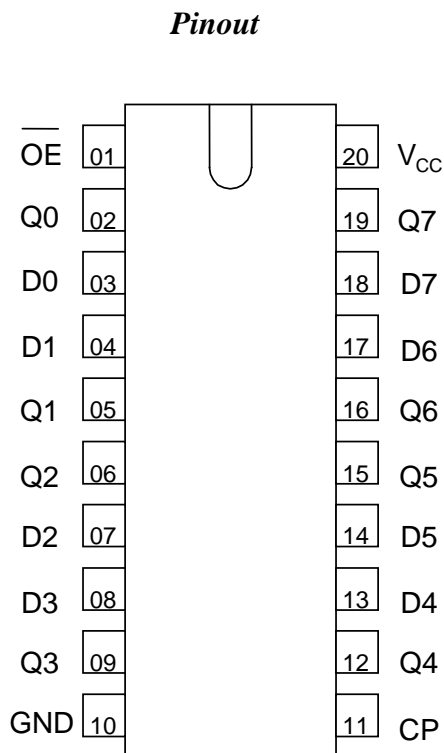
- Supply voltage range 4.5 to 5.5 V.
- Output current 8 mA.
- Low consumption current: 0.2 mA (typical value) at T<sub>a</sub> = 25 °C.
- Latchup current not less than 300 mA at T<sub>a</sub> = 85 °C.
- Tolerable value of static potential not less than 2000 V as per human body model (HBM) and not less than 200 V as per machine model (MM).
- Ambient operation temperature minus 40 to plus 85 °C.
- Balanced signal propagation delay.
- Ensures voltage exceeding mode on input
- Low noise level at the simultaneous switching of outputs in the same state:  
 V<sub>OLP</sub> = 0.8 V (max).

IN74VHCT374 truth table

Input			Output
$\overline{OE}$	CP	D	Q
L		H	H
L		L	L
L	L, H,	X	Q <sub>0</sub>
H	X	X	Z

**Note –**  
 H - high voltage level;  
 L – low voltage level;  
 X - any voltage level (low or high);  
 Q<sub>0</sub> - storage of the previous state;  
 Z - output in the third  
 - transition from low into high level;  
 - transition from high into low level

Pins description in IN74VHCT374



Pin No.	Symbol	Description
01	$\overline{OE}$	Input <b>OUTPUT ENABLE</b>
02	Q0	Data output
03	D0	Data input
04	D1	Data input
05	Q1	Data output
06	Q2	Data output
07	D2	Data input
08	D3	Data input
09	Q3	Data output
10	GND	Common output
11	<b>CP</b>	Input of clock signal
12	Q4	Data output
13	D4	Data input
14	D5	Data input
15	Q5	Data output
16	Q6	Data output
17	D6	Data input
18	D7	Data input
19	Q7	Data output
20	V <sub>cc</sub>	Supply output from voltage source

**Absolute maximum conditions\***

Parameter, unit	Symbol	Value	
		min	max
Supply voltage, V	$V_{CC}$	-0.5	7.0
Input voltage, V	$V_{in}$	-0.5	7.0
Output voltage, V	$V_{out}$	-0.5	$V_{CC} + 0.5B$
Output voltage, V	$V_{out1}$	-0.5	7.0
Input diode current, mA	$I_{ik}$	-	-20
Current of common output and supply output, mA	$I_{cc}$		$\pm 75$
Output current, mA	$I_{out}$		$\pm 25$
Output diode current, mA	$I_{ok}$		$\pm 20$
Dissipated power, mW	$P_d$		180

\*Under absolute maximum conditions operation of microcircuit is not guaranteed. Operation is guaranteed under maximum conditions

**Maximum conditions**

Parameter, unit	Symbol	Value	
		min	max
Supply voltage, V	$V_{CC}$	4.5	5.5
Input voltage, V	$V_{in}$	0	$V_{CC}$
Output voltage, V	$V_{out}$	0	$V_{CC}$
Output voltage, V	$V_{out1}$	0	5.5*
Output current, mA	$I_{out}$	-	$\pm 8.0$
Input rise and fall time, ns/V	$t_{LH}, t_{HL}$	0	20

\* - For ICs without third state on outputs –  $V_{cc} = 0V$ , for ICs with third state on outputs – outputs should be in third state

## DC electrical characteristics

Symbol	Parameter	Test conditions	V <sub>CC</sub> , V	Value				Unit
				25 °C		-40 to 85 °C		
				min	max	min	max	
V <sub>IH</sub>	High input voltage	V <sub>O</sub> ≤ 0.1 V or V <sub>O</sub> ≥ V <sub>CC</sub> - 0.1	4.5 – 5.5	2.0	-	2.0	-	V
V <sub>IL</sub>	Low input voltage	V <sub>O</sub> ≤ 0.1 V or V <sub>O</sub> ≥ V <sub>CC</sub> - 0.1	4.5 – 5.5	-	0.8	-	0.8	
V <sub>OH</sub>	High output voltage	V <sub>I</sub> = V <sub>IH</sub> or V <sub>IL</sub> I <sub>O</sub> = -50 mA	4.5 5.5	4.42 5.42	-	4.4 5.4	-	
		V <sub>I</sub> = V <sub>IH</sub> or V <sub>IL</sub> ; I <sub>O</sub> = -8 mA	4.5	3.94	-	3.80	-	
V <sub>OL</sub>	Low output voltage	V <sub>I</sub> = V <sub>IH</sub> or V <sub>IL</sub> I <sub>O</sub> = 50 mA	4.5 5.5	-	0.09	-	0.1	
		V <sub>I</sub> = V <sub>IH</sub> or V <sub>IL</sub> I <sub>O</sub> = 8 mA	4.5	-	0.36	-	0.44	
I <sub>OZ</sub>	Output current in "off" state	V <sub>I</sub> = 2.0V V <sub>O</sub> = V <sub>CC</sub> or 0V	5.5	-	±0.25	-	±2.5	
I <sub>I</sub>	Input current	V <sub>I</sub> = 0 V or V <sub>CC</sub>	5.5		±0.1		±1.0	
I <sub>IHI</sub>	High level input current	V <sub>I</sub> = 5.5V	0	-	±0.1	-	±1.0	uA
I <sub>CC</sub>	Consumption current	V <sub>I</sub> = V <sub>CC</sub> or 0V	5.5	-	4.0	-	40.0	
I <sub>CCT</sub>	TTL-input consumption current	V <sub>I</sub> = 3.4 V	5.5	-	1.35	-	1.5	mA

**AC electrical characteristics** ( $t_{LH} = t_{HL} = 3.0$  ns,  $R_L = 1$  kOhm)

Symbol	Parameter	Test conditions	$V_{CC}, V$	$C_L, pF$	Value				Unit
					25 °C		-40 to 85 °C		
					min	max	min	max	
$t_{PHL}, t_{PLH}$	Propagation delay time when switching "on", "off" from input CP to output Q	Fig 1	$5.0 \pm 0.5$	15	–	9.4	–	10.5	ns
				50	–	10.4	–	11.5	
$t_{PHZ}, t_{PLZ}$	Propagation delay time under transition from high, low level into "off" state	Fig 2	$5.0 \pm 0.5$	50	–	11.2	–	12.0	ns
$t_{PZH}, t_{PZL}$	Propagation delay time under transition from «off» state into high, low level	Fig 2	$5.0 \pm 0.5$	15	–	10.2	–	11.5	ns
				50	–	11.4	–	13.0	
$t_{SU}$	Time of setting signal D to CP	Fig 3	$5.0 \pm 0.5$	15	2.5	–	2.5	–	ns
				50	2.5	–	2.5	–	
$t_H$	Retention time, D signal to CP	Fig 3	$5.0 \pm 0.5$	15	2.5	–	2.5	–	
				50	2.5	–	2.5	–	
$t_W$	Pulse duration of CP signal	Fig 3	$5.0 \pm 0.5$	15	6.5	–	8.5	–	
				50	6.5	–	8.5	–	
$t_{OSLH}, t_{OSHL}$	Propagation delays difference between outputs	–	$5.5 \pm 0.5$	50	–	1.0	–	1.0	
$f_C$	Clock pulses maximum frequency	Fig 4	$5.0 \pm 0.5$	15	–	90	–	80	MHz
				50	–	85	–	75	

**Capacitance characteristics**

Symbol	Parameter	Test conditions	$V_{CC}, V$	Value		Unit
				25 °C		
				min	max	
$C_I$	Input capacity	–	5.0		10	pF
$C_O$	Output capacity	–	5.0		18	pF
$C_{PD}$	Dynamic capacity	$V_I = 0 V$ or $V_{CC}$	5.0		64	pF

Noise characteristics ( $C_L = 50 \text{ pF}$ )

Symbol	Parameter	$V_{CC}, \text{ V}$	Value		Unit
			min	max	
$V_{OLP}$	Positive noise of low output voltage	5.0	-	0.9	V
$V_{OLV}$	Negative noise of low output voltage	5.0	-0.9	-	
$V_{IHD}$	Input dynamic high voltage	5.0	3.5		
$V_{ILD}$	Input dynamic low voltage	5.0		1.5	

- - Time diagram of input and output pulses

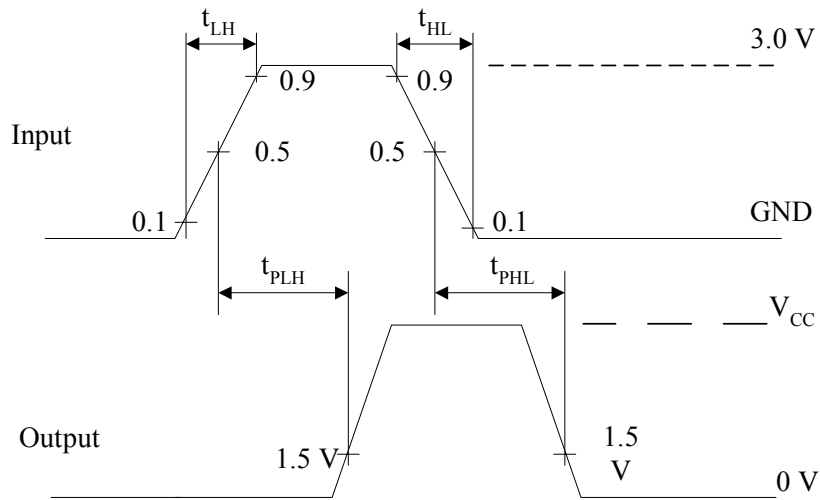


Fig. 1

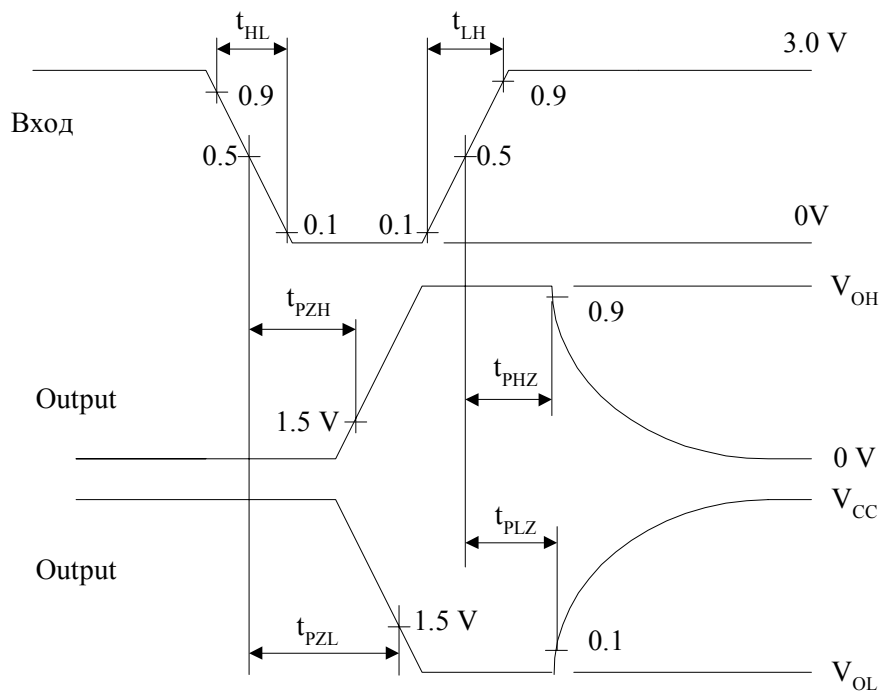
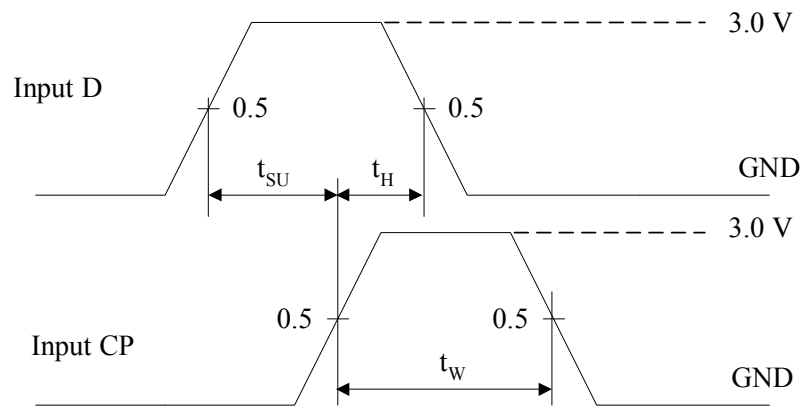


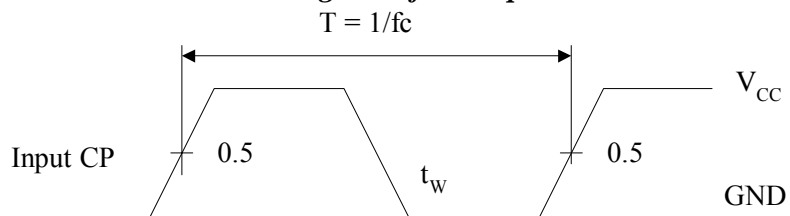
Fig. 2

*Time diagram of input pulses*



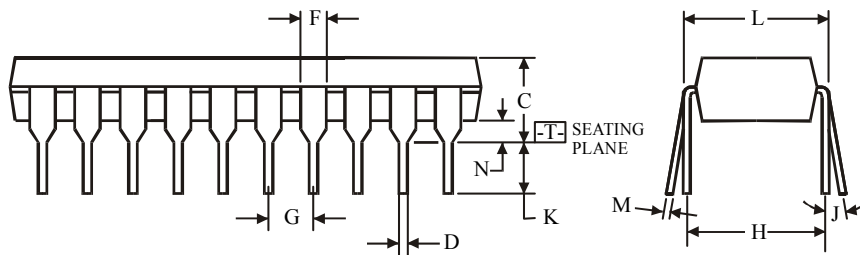
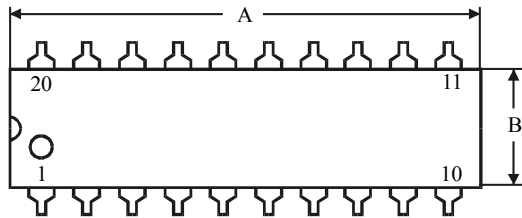
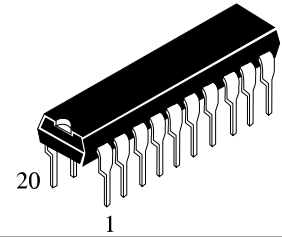
**Fig. 3**

*Time diagram of clock pulses*



**Fig. 4**

**N SUFFIX PLASTIC DIP**  
(MS - 001AD)



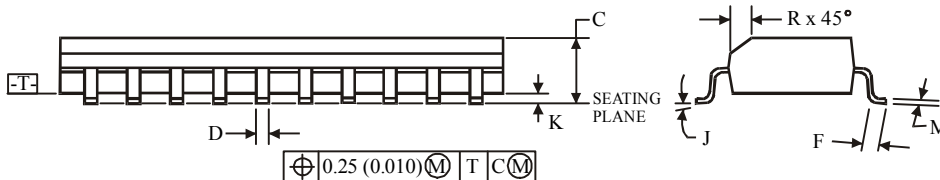
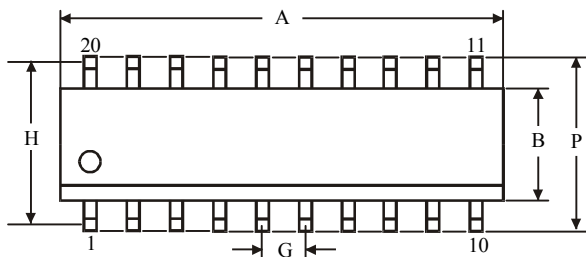
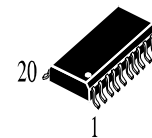
$\oplus 0.25 (0.010) \text{ (M) T}$

**NOTES:**

- Dimensions "A", "B" do not include mold flash or protrusions.  
Maximum mold flash or protrusions 0.25 mm (0.010) per side.

Symbol	Dimension, mm	
	MIN	MAX
A	24.89	26.92
B	6.1	7.11
C		5.33
D	0.36	0.56
F	1.14	1.78
G	2.54	
H	7.62	
J	0°	10°
K	2.92	3.81
L	7.62	8.26
M	0.2	0.36
N	0.38	

**D SUFFIX SOIC**  
(MS - 013AC)



$\oplus 0.25 (0.010) \text{ (M) T C (M)}$

**NOTES:**

- Dimensions A and B do not include mold flash or protrusion.
- Maximum mold flash or protrusion 0.15 mm (0.006) per side for A; for B - 0.25 mm (0.010) per side.

Symbol	Dimension, mm	
	MIN	MAX
A	12.6	13
B	7.4	7.6
C	2.35	2.65
D	0.33	0.51
F	0.4	1.27
G	1.27	
H	9.53	
J	0°	8°
K	0.1	0.3
M	0.23	0.32
P	10	10.65
R	0.25	0.75